

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10599644	PERNER, PETRA
	<b>Examiner</b>	<b>Art Unit</b>
	PETER COUGHLAN	2129

## SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
411	344	5/21/2010	PDC

## SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Inventor, Petra Perner	5/20/2010	PDC
Google -- Petra Perner, HEp-2, tracing, outline, classification	5/20/2010	PDC
IEEE -- Perner, HEp-2, classification	5/20/2010	PDC
East -- @pd<20040408 and manually, trace, outline, image, device, HEP-2, HEP2, HEP 2, pen, input, carrier, rotation, cell, indicate, chart, delineate, depict, record, sketch, manual, center, centroid, orient, distance matrix, intersect, similarity, origin, average, mean	5/21/2010	PDC
East -- @pd<20040408 and 706/20 w/"data mining"	5/21/2010	PDC

## INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

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